

# **RIBF Detector Workshop 08**

## **Report of Contributions**

Contribution ID: 1

Type: **not specified**

## **PPAC for RIBF**

*Monday, 17 March 2008 13:30 (45 minutes)*

**Presenter:** KUMAGAI, H. (RIKEN Nishina Center)

**Session Classification:** Position Detector I

Contribution ID: 2

Type: **not specified**

## **MWPC/DC for heavy ion**

*Monday, 17 March 2008 14:15 (30 minutes)*

**Presenter:** T. KOBAYASHI (Tohoku U.)

**Session Classification:** Position Detector I

Contribution ID: 3

Type: **not specified**

## Low Pressure MWPC

*Monday, 17 March 2008 14:45 (30 minutes)*

**Presenter:** K. OZEKI (RIKEN Nishina Center)

**Session Classification:** Position Detector I

Contribution ID: 4

Type: **not specified**

## **Fiber scintillation detector for momentum dispersive focal plane**

*Monday, 17 March 2008 15:35 (30 minutes)*

**Presenter:** Y. MATSUDA (Tohoku U.)

**Session Classification:** Position Detector II

Contribution ID: 5

Type: **not specified**

## **Beamline Detector for SHARAQ**

*Monday, 17 March 2008 16:50 (30 minutes)*

**Presenter:** Dr SAITO, Akito (Department of Physics, University of Tokyo)

**Session Classification:** Position Detector III

Contribution ID: 6

Type: **not specified**

## **Focal Plane Detector for SHARAQ**

*Monday, 17 March 2008 17:20 (30 minutes)*

**Presenter:** S. MICHIMASA (CNS)

**Session Classification:** Position Detector III

Contribution ID: 7

Type: **not specified**

## **High resolution TOF measurement with plastic scintillator**

*Tuesday, 18 March 2008 15:00 (20 minutes)*

**Presenter:** YAMAGUCHI, T. (Saitama U.)

**Session Classification:** Future Detector II



Contribution ID: 8

Type: **not specified**

## **CsI(Pure) detector for heavy ion under high rate condition**

*Tuesday, 18 March 2008 15:35 (15 minutes)*

**Presenter:** TERASHIMA, Satoru (RIKEN Nishina Center)

**Session Classification:** Future Detector II

Contribution ID: 9

Type: **not specified**

## **LYSO detector**

*Tuesday, 18 March 2008 15:20 (15 minutes)*

**Presenter:** AKIMUNE, H. (Konan U.)

**Session Classification:** Future Detector II

Contribution ID: 13

Type: **not specified**

## **Focal Plane detector for GARIS**

*Tuesday, 18 March 2008 09:30 (20 minutes)*

**Presenter:** MORIMOTO, K. (RIKEN Nishina Center)

**Session Classification:** Si Detectors

Contribution ID: 14

Type: **not specified**

## **Beam line detectors for BigRIPS**

*Monday, 17 March 2008 10:50 (30 minutes)*

**Presenter:** Dr OHNISHI, Tetsuya (RIKEN Nishina Center)

**Session Classification:** RIBF Standard Detector – Overview

Contribution ID: 15

Type: **not specified**

## **Intensity monitor for BigRIPS**

*Monday, 17 March 2008 11:20 (20 minutes)*

**Presenter:** YOSHIDA, A. (RIKEN Nishina Center)

**Session Classification:** RIBF Standard Detector – Overview

Contribution ID: 16

Type: **not specified**

## Development of High Rate Ion Chamber

*Monday, 17 March 2008 12:00 (30 minutes)*

**Presenter:** KIMURA, K. (Nagasaki Sogo U.)

**Session Classification:** RIBF Standard Detector – Overview

Contribution ID: 17

Type: **not specified**

## Si Micro Pixel Detector

*Tuesday, 18 March 2008 09:50 (30 minutes)*

**Presenter:** TAKETANI, A. (RIKEN Nishina Center)

**Session Classification:** Si Detectors

Contribution ID: **18**

Type: **not specified**

## **Silicon strip detectors and plastic scintillator hodoscope for Coulomb-dissociation experiments**

*Tuesday, 18 March 2008 10:20 (30 minutes)*

**Presenter:** Dr IWASA, Naohito (Department of Physics, Tohoku University)

**Session Classification:** Si Detectors



Contribution ID: **20**

Type: **not specified**

# Welcome

Contribution ID: 21

Type: **not specified**

## **GEM for heavy ion**

*Tuesday, 18 March 2008 11:05 (30 minutes)*

**Presenter:** TAMAGAWA, T. (RIKEN)

**Session Classification:** Future Detector I

Contribution ID: 22

Type: **not specified**

## TPC with GEM

*Tuesday, 18 March 2008 11:35 (30 minutes)*

**Presenter:** MIZOI, Y. (Osaka Electro-Communication U.)

**Session Classification:** Future Detector I

Contribution ID: **23**

Type: **not specified**

# Welcome

**Presenter:** T. OHNISHI

Contribution ID: 24

Type: **not specified**

## **Intensity monitor for GARIS**

*Monday, 17 March 2008 11:40 (20 minutes)*

**Presenter:** KAJI, D. (RIKEN Nishina Center)

**Session Classification:** RIBF Standard Detector – Overview

Contribution ID: 25

Type: **not specified**

## Welcome

*Monday, 17 March 2008 10:00 (10 minutes)*

**Presenter:** Dr OHNISHI, Tetsuya (RIKEN Nishina Center)

**Session Classification:** Experimental Requirements

Contribution ID: 26

Type: **not specified**

## **Requirements of detectors for BigRIPS/ZeroDegree**

*Monday, 17 March 2008 10:10 (10 minutes)*

**Presenter:** Dr OHNISHI, Tetsuya (RIKEN Nishina Center)

**Session Classification:** Experimental Requirements

Contribution ID: 27

Type: **not specified**

## **Requirements of detectors for SAMURAI**

*Monday, 17 March 2008 10:20 (10 minutes)*

**Presenter:** T. KOBAYASHI (Tohoku U.)

**Session Classification:** Experimental Requirements



Contribution ID: 28

Type: **not specified**

## Requirements of detectors for SHARAQ

*Monday, 17 March 2008 10:30 (10 minutes)*

**Presenter:** Prof. UESAKA, T. (CNS)

**Session Classification:** Experimental Requirements

Contribution ID: **30**

Type: **not specified**

**(no title)**

*Monday, 17 March 2008 18:00 (2 hours)*

**Session Classification:** Party

Contribution ID: 31

Type: **not specified**

## **NaI(Tl) and CsI(Tl) for heavy ion**

*Tuesday, 18 March 2008 15:50 (15 minutes)*

**Presenter:** Dr OTSU, Hideaki (RIKEN Nishina Center)

**Session Classification:** Future Detector II

Contribution ID: **32**

Type: **not specified**

## **Beam property of MCP beam monitor**

*Monday, 17 March 2008 16:15 (15 minutes)*

**Presenter:** S. HAYAKAWA (CNS)

**Session Classification:** Position Detector II

Contribution ID: 33

Type: **not specified**

## High resolution scintillation-fiber detector

*Monday, 17 March 2008 16:05 (10 minutes)*

**Presenter:** MORIMOTO, K. (RIKEN Nishina Center)

**Session Classification:** Position Detector II